

ABSTRACT OF THE DISCLOSURE

An IC measuring device constituted by a first timing generator (TG21) for outputting a pair of judgment strobe pulses (S21); a first edge detector (E21) for detecting the states of a data strobe (DCK2) at two time points within one test cycle on the basis of the pair of judgment strobe pulses (S21); a second timing generator (TG22) for outputting a pair of judgment strobe pulses (S22); a second edge detector (E22) for detecting the states of data at two time points within one test cycle on the basis of the pair of judgment strobe pulses (S22); and a judgment section (J22) for determining acceptance/rejection of the timing of the data with reference to the data strobe on the basis of the states of the data and the states of the data strobe.